Notice of References Cited

Application/Control No. 10/531,491	Applicant(s)/Pater Reexamination WARIS, HEIKKI			
Examiner	Art Unit			
Andrew C. Lee	2419	Page 1 of 1		

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0085518	07-2002	Lim, Byung Keun	370/331
*	В	US-2002/0085517	07-2002	Lee et al.	370/331
*	С	US-2004/0017905	01-2004	Warrier et al.	379/114.15
*	D	US-7,120,131	10-2006	Seppala et al.	370/310
*	Е	US-2004/0203787	10-2004	Naghian, Siamak	455/437
*	F	US-7,478,167	01-2009	Ould-Brahim et al.	709/238
*	G	US-6,728,536	04-2004	Basilier et al.	455/432.1
*	Н	US-6,885,658	04-2005	Ress et al.	370/352
	Т	US-			
	J	US-			
	к	US-			
	L	US-			
	м	US-			

	FOREIGN PATENT DOCUMENTS					
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
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	Т					

NON DATENT DOCUMENTS

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